HALOGEN

FREE

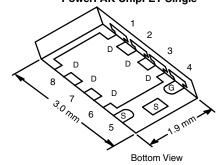
Vishay Siliconix



N-Channel 20 V (D-S) MOSFET

PRODUC	JCT SUMMARY				
V _{DS} (V)	$R_{DS(on)}\left(\Omega\right)$ Max.	I _D (A) ^a	Q _g (Typ.)		
	0.0100 at V _{GS} = 4.5 V	25			
20	0.0115 at V _{GS} = 2.5 V	25	16.6 nC		
	0.0135 at V _{GS} = 1.8 V	25			

PowerPAK ChipFET Single



Ordering Information:

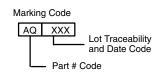
Si5442DU-T1-GE3 (Lead (Pb)-free and Halogen-free)

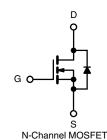
FEATURES

- TrenchFET® Power MOSFET
- Thermally Enhanced PowerPAK® ChipFET® Package
 - Small Footprint Area
 - Low On-Resistance
 - Thin 0.8 mm Profile
- 100% R_a Tested
- Material categorization: For definitions of compliance please see www.vishay.com/doc?99912

APPLICATIONS

- Load Switch, PA Switch, and for Portable Applications
- Point-of-Load
- DC/DC Converters
- **Power Management**





ABSOLUTE MAXIMUM RATIN	IGS (T _A = 25 °C	, unless otherw	ise noted)	
Parameter		Symbol	Limit	Unit
Drain-Source Voltage		V _{DS}	20	V
Gate-Source Voltage		V _{GS}	± 8	v
	T _C = 25 °C		25 ^a	
Continuous Drain Current (T _{.1} = 150 °C)	T _C = 70 °C	I_	25 ^a	
Continuous Drain Current (1) = 130 C)	T _A = 25 °C	l _D	12.4 ^{b, c}	
	T _A = 70 °C		9.9 ^{b, c}	A
Pulsed Drain Current (t = 300 μs)		I _{DM}	60	
Continuous Source-Drain Diode Current	T _C = 25 °C		25 ^a	
Continuous Source-Drain Diode Current	T _A = 25 °C	I _S	2.6 ^{b, c}	
	T _C = 25 °C		31	
Maximum Power Dissipation	T _C = 70 °C	P _D	20	w
Maximum Fower Dissipation	T _A = 25 °C	' D	3.1 ^{b, c}	VV
	T _A = 70 °C		2 ^{b, c}	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to 150	°C
Soldering Recommendations (Peak Temperature) ^{d, e}			260	

THERMAL RESISTANCE RA	TINGS				
Parameter		Symbol	Typical	Maximum	Unit
Maximum Junction-to-Ambient ^{b, f}	t ≤ 5 s	R _{thJA}	34	40	°C/W
Maximum Junction-to-Case (Drain)	Steady State	R _{th.IC}	3	4	O/ VV

Notes:

- a. Package limited.
- b. Surface mounted on 1" x 1" FR4 board.
- d. See solder profile (www.vishay.com/doc273257). The PowerPAK ChipFET is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- e. Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.
- f. Maximum under steady state conditions is 90 °C/W.

Document Number: 63233 S13-2149-Rev. B, 14-Oct-13 For technical questions, contact: pmostechsupport@vishay.com

www.vishay.com

Si5442DU

Vishay Siliconix



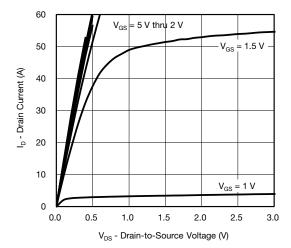
SPECIFICATIONS $(T_J = 25 ^{\circ}\text{C})$, uniess oth					
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Static						
Drain-Source Breakdown Voltage	V_{DS}	$V_{GS} = 0 \text{ V, } I_D = 250 \mu\text{A}$	20			V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I _D = 250 μA		21		V mV/°C V nA μA A Ω S S PF nC Ω Ω NS nS nC
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	η – 200 μΛ		- 3		
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_D = 250 \mu A$	0.4		0.9	V
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 8 \text{ V}$			± 100	nA
Zara Cata Valtaga Drain Current	1	V _{DS} = 20 V, V _{GS} = 0 V			1	μΑ
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = 20 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$			10	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 4.5 \text{ V}$	20			Α
		$V_{GS} = 4.5 \text{ V}, I_D = 8 \text{ A}$		0.0080	0.0100	
Drain-Source On-State Resistance ^a	R _{DS(on)}	$V_{GS} = 2.5 \text{ V}, I_D = 7 \text{ A}$		0.0090	0.0115	Ω
		$V_{GS} = 1.8 \text{ V}, I_D = 4 \text{ A}$		0.0100	0.0135	
Forward Transconductance ^a	9 _{fs}	V _{DS} = 10 V, I _D = 8 A		65		S
Dynamic ^b				I.	<u> </u>	
Input Capacitance	C _{iss}			1700		
Output Capacitance	C _{oss}	$V_{DS} = 10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		280		pF
Reverse Transfer Capacitance	C _{rss}	35		115		· .
·	100	V _{DS} = 10 V, V _{GS} = 8 V, I _D = 15 A		29	45	
Total Gate Charge	Q_g	20 40 2		16.6	25	_
Gate-Source Charge	Q _{gs}	$V_{DS} = 10 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 15 \text{ A}$		1.9		nC
Gate-Drain Charge	Q _{gd}	- DS		2		
Gate Resistance	R _g	f = 1 MHz	0.28	1.4	2.8	Ω
Turn-on Delay Time	t _{d(on)}			10	20	
Rise Time	t _r	V_{DD} = 10 V, R_L = 1 Ω		15	30	
Turn-Off Delay Time	t _{d(off)}	$I_D\cong$ 10 A, V_{GEN} = 4.5 V, R_g = 1 Ω		35	70	1
Fall Time	t _f			10	20	
Turn-On Delay Time	t _{d(on)}			10	20	ns
Rise Time	t _r	V_{DD} = 10 V, R_L = 1 Ω		10	20	
Turn-Off Delay Time	t _{d(off)}	$I_D\cong$ 10 A, V_{GEN} = 8 V, R_g = 1 Ω		30	60	
Fall Time	t _f			10	20	1
Drain-Source Body Diode Characteristi						
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			25	
Pulse Diode Forward Current	I _{SM}	-			60	A
Body Diode Voltage	V _{SD}	I _S = 10 A, V _{GS} = 0 V		0.8	1.2	V
Body Diode Reverse Recovery Time	t _{rr}			20	40	ns
Body Diode Reverse Recovery Charge	Q _{rr}			10	20	
Reverse Recovery Fall Time	t _a	$I_F = 10 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$		11		+
Reverse Recovery Rise Time	t _b	<u> </u>		9		ns

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

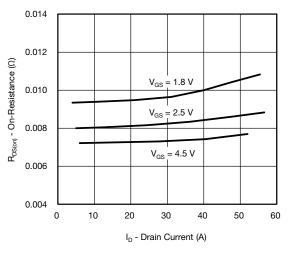
a. Pulse test; pulse width \leq 300 μ s, duty cycle \leq 2 % b. Guaranteed by design, not subject to production testing.



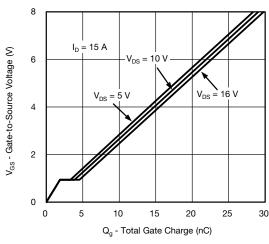
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



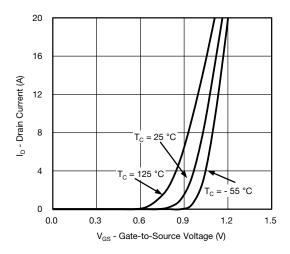
Output Characteristics



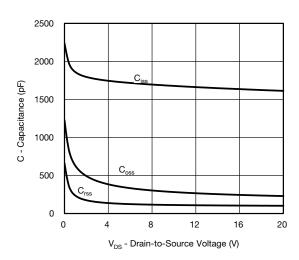
On-Resistance vs. Drain Current and Gate Voltage



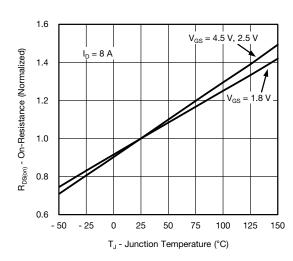
Gate Charge



Transfer Characteristics



Capacitance

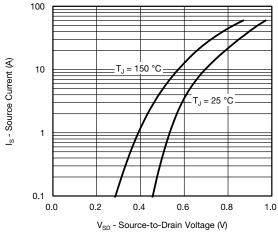


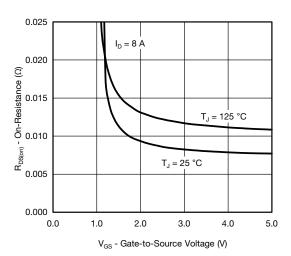
On-Resistance vs. Junction Temperature

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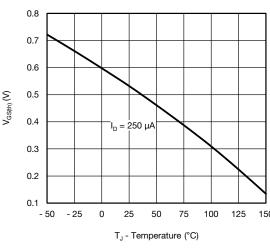
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

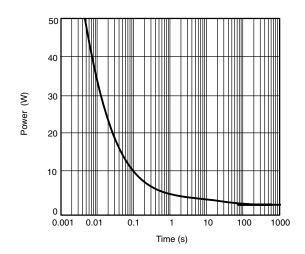




Source-Drain Diode Forward Voltage

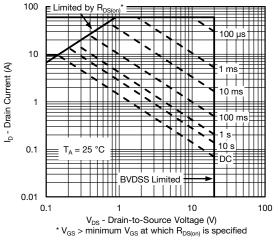
On-Resistance vs. Gate-to-Source Voltage



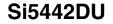


Threshold Voltage

Single Pulse Power, Junction-to-Ambient



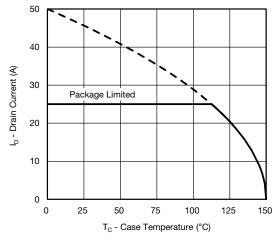
Safe Operating Area, Junction-to-Ambient

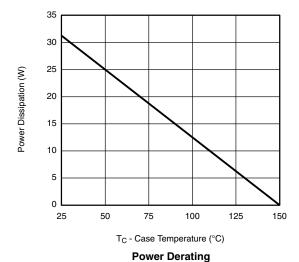






TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)





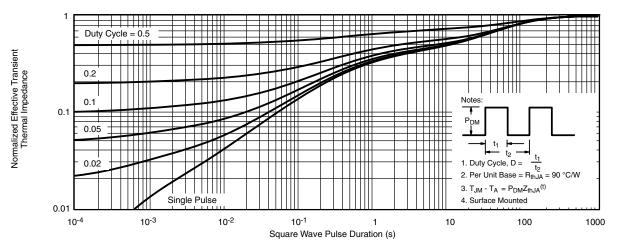
Current Derating*

 $^{^*}$ The power dissipation P_D is based on $T_{J(max.)}$ = 150 $^{\circ}$ C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

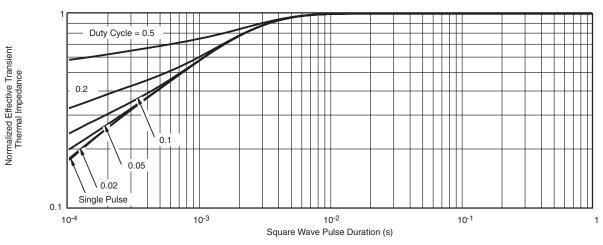
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TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient

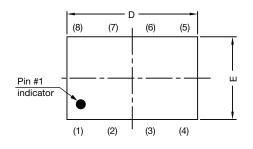


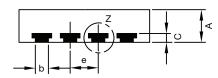
Normalized Thermal Transient Impedance, Junction-to-Case

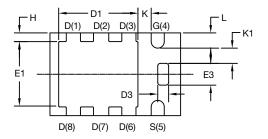
Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see www.vishay.com/ppg?63233.



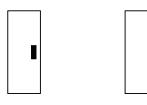
PowerPAK® ChipFET® Case Outline



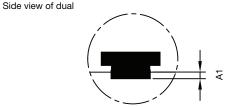




Backside view of single pad



Side view of single



Detail Z

D1(8) D1(7) D2(6) D2(5)

K3

Backside view of dual pad

DIM.		MILLIMETERS			INCHES			
	MIN.	NOM.	MAX.	MIN.	NOM.	MAX.		
Α	0.70	0.75	0.85	0.028	0.030	0.033		
A1	0	-	0.05	0	-	0.002		
b	0.25	0.30	0.35	0.010	0.012	0.014		
С	0.15	0.20	0.25	0.006	0.008	0.010		
D	2.92	3.00	3.08	0.115	0.118	0.121		
D1	1.75	1.87	2.00	0.069	0.074	0.079		
D2	1.07	1.20	1.32	0.042	0.047	0.052		
D3	0.20	0.25	0.30	0.008	0.010	0.012		
E	1.82	1.90	1.98	0.072	0.075	0.078		
E1	1.38	1.50	1.63	0.054	0.059	0.064		
E2	0.92	1.05	1.17	0.036	0.041	0.046		
E3	0.45	0.50	0.55	0.018	0.020	0.022		
е		0.65 BSC		0.026 BSC				
Н	0.15	0.20	0.25	0.006	0.008	0.010		
K	0.25	-	-	0.010	-	-		
K1	0.30	-	-	0.012	-	-		
K2	0.20	-	-	0.008	-	-		
K3	0.20	-	-	0.008	-	-		
L	0.30	0.35	0.40	0.012	0.014	0.016		

C14-0630-Rev. E, 21-Jul-14

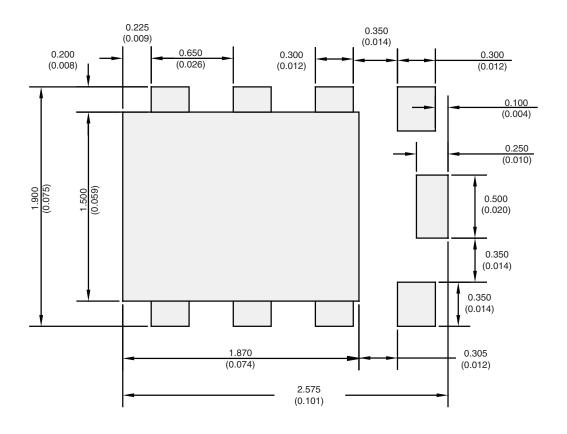
DWG: 5940

• Millimeters will govern

Revision: 21-Jul-14 1 Document Number: 73203



RECOMMENDED MINIMUM PADS FOR PowerPAK® ChipFET® Single



Recommended Minimum Pads Dimensions in mm/(Inches)

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APPLICATION NOTE

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